

AOD516/AOI516/AOY516

30V N-Channel AlphaMOS

General Description

- Latest Trench Power MOSFET technology
- Very Low R_{DS(on)} at 4.5V V_{GS}
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

Application

- DC/DC Converters in Computing
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

30V I_D (at V_{GS} =10V) 46A $R_{DS(ON)}$ (at V_{GS} =10V) $< 5 \text{m}\Omega$ $R_{DS(ON)}$ (at $V_{GS} = 4.5V$) $< 10 \text{m}\Omega$

100% UIS Tested 100% R_q Tested



Units

TO252 DPAK: AOD516 TO-251B IPAK: AOI516/AOY516 Top View **Bottom View Bottom View**



Absolute Maximum Ratings T_A=25℃ unless otherwise noted Parameter Symbol Maximum Drain-Source Voltage V_{DS}

Gate-Source Voltage V_{GS} ±20 ٧ T_C=25℃ 46 Continuous Drain I_D Current G T_C=100℃ 36 Α Pulsed Drain Current C 170 I_{DM} T_A=25℃ 18 Continuous Drain Α I_{DSM} T_A=70℃ 14 Current Avalanche Current C 29 I_{AS} Avalanche energy L=0.1mH ^C 42 mJ E_AS 36 V_{DS} Spike 100ns V V_{SPIKE} T_C=25℃ 50 P_D W Power Dissipation B T_C=100℃ 25 T_A=25℃ 2.5 W P_{DSM} Power Dissipation A T_A=70℃ 1.6 T_J, T_{STG} Junction and Storage Temperature Range -55 to 175 \mathcal{C}

Thermal Characteristics									
Parameter		Symbol Typ		Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	16	20	€/M				
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	41	50	€/W				
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	2.5	3	€/M				



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Parameter Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V				1	μА
	Zero Gate Voltage Drain Current	T _J				5	μΑ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.8	2.2	2.6	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A			4	5	mΩ
			T _J =125℃		5.4	6.8	
		V_{GS} =4.5V, I_D =20A			7.1	10	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			83		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V
Is	Maximum Body-Diode Continuous Current ^G					46	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			1333		pF
C _{oss}	Output Capacitance				512		pF
C_{rss}	Reverse Transfer Capacitance			42		pF	
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.8	1.7	2.6	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	-V _{GS} =10V, V _{DS} =15V, I _D =20A			18.3	33	nC
Q _g (4.5V)	Total Gate Charge				8.5	17	nC
Q_{gs}	Gate Source Charge				4.8		nC
Q_{gd}	Gate Drain Charge				2.5		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =15V, R_L =0.75 Ω , R_{GEN} =3 Ω			7.5		ns
t _r	Turn-On Rise Time				4.8		ns
t _{D(off)}	Turn-Off DelayTime				23.3		ns
t _f	Turn-Off Fall Time				4.5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs			14.1		ns
Q _{rr}	Body Diode Reverse Recovery Charge I _F =20A, dI/dt=500A/μs			16.2		nC	

A. The value of $R_{a|a}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_a =25° C. The Power dissipation P_{DSM} is based on R _{8JA} and the maximum allowed junction temperature of 150° C. The value in any given application depends

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on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

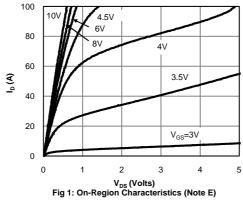
C. Single pulse width limited by junction temperature T_{J(MAX)}=175° C.

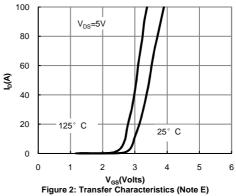
D. The $R_{0,L}$ is the sum of the thermal impedance from junction to case $R_{0,C}$ and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

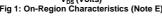
E. The static characteristics in Figures 1 to 8 are obtained using color: blue; of the static characteristics in Figures 1 to 8 are obtained using color: blue; of the static characteristics in Figures 1 to 8 are obtained using color: blue; of the static characteristics in Figures 1 to 8 are obtained using color: blue; of the static characteristics in Figures 1 to 8 are obtained using color: blue; of the static characteristics in Figures 2. The static characteristics 2. The static

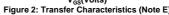


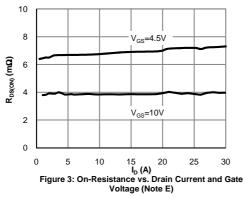
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

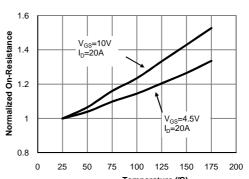




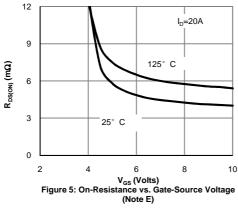


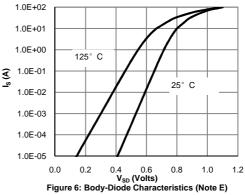






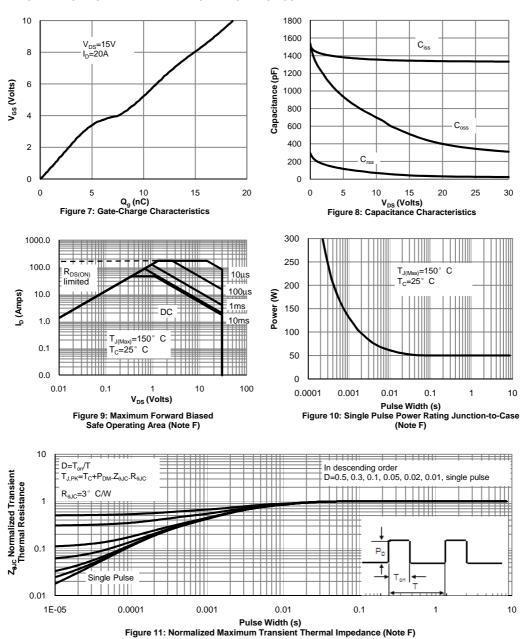
Temperature (℃) Figure 4: On-Resistance vs. Junction Temperature (Note E)





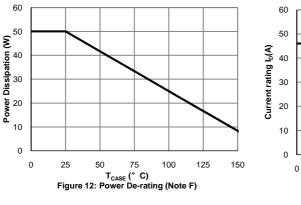


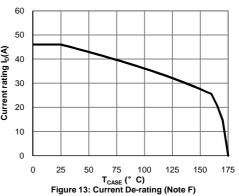
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

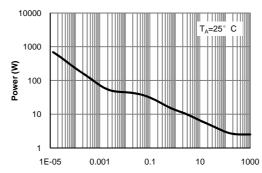




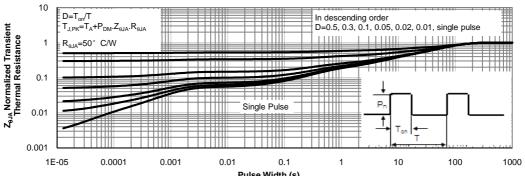
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS







Pulse Width (s)
Figure 14: Single Pulse Power Rating Junction-toAmbient (Note H)

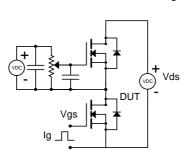


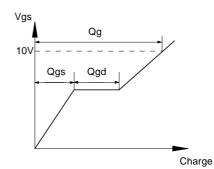
Pulse Width (s)
Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Rev.5.0: July 2013 **www.aosmd.com** Page 5 of 6

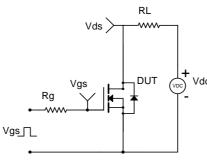


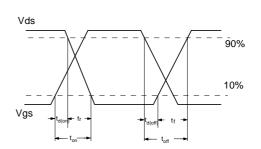
Gate Charge Test Circuit & Waveform



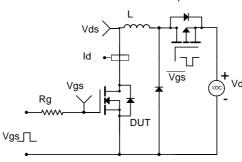


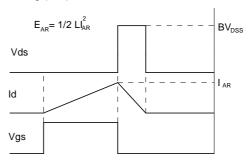
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

